

**PCN# 20141204000**  
**Qualification of TI Chengdu as Additional Assembly and Test Site**  
**for Select VQFN/WQFN Package Devices**  
**Change Notification / Sample Request**

**Date:** 12/16/2014  
**To:** MOUSER PCN

Dear Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

We request you acknowledge receipt of this notification within **30** days of the date of this notice. Lack of acknowledgement of this notice within 30 days constitutes acceptance of the change. If you require samples or additional data to support your evaluation, please request within 30 days.

The changes discussed within this PCN will not take effect any earlier than **90** days from the date of this notification, unless customer agreement has been reached on an earlier implementation of the change. This notification period is per TI's standard process.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Manager ([PCN\\_ww\\_admin\\_team@list.ti.com](mailto:PCN_ww_admin_team@list.ti.com)).

Sincerely,

PCN Team  
SC Business Services  
Phone: +1(214) 480-6037  
Fax: +1(214) 480-6659

**20141204000**  
**Attachment: 1**

**Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

<b>DEVICE</b>	<b>CUSTOMER PART NUMBER</b>
BQ24040DSQR	null
BQ24040DSQT	null
BQ24190RGET	null
BQ24192IRGET	null
BQ24192RGET	null
BQ24193RGET	null
BQ24195LRGET	null
BQ24196RGET	null
BQ24232HRGTT	null
BQ24232RGTT	null
BQ24295RGET	null
BQ24296RGET	null
BQ24297RGET	null
MSP430F2112IRHBT	null
MSP430F2112TRHBT	null
MSP430F2122IRHBR	null
MSP430F2122IRHBT	null
MSP430F2132IRHBR	null
MSP430F2132IRHBT	null
MSP430F2132TRHBT	null
MSP430G2153IRHB32T	null
MSP430G2253IRHB32T	null
MSP430G2303IRHB32T	null
MSP430G2333IRHB32R	null
MSP430G2333IRHB32T	null
MSP430G2403IRHB32T	null
MSP430G2413IRHB32T	null
MSP430G2433IRHB32R	null
MSP430G2433IRHB32T	null
MSP430G2513IRHB32T	null
MSP430G2533IRHB32T	null
MSP430G2553IRHB32R	null
MSP430G2553IRHB32T	null
TLV62065DSGR	null
TLV62065DSGT	null
TLV62130ARGTT	null
TLV62130RGTR	null
TLV62130RGTT	null
TLV62150ARGTT	null
TLV62150RGTT	null
TPA2012D2RTJR	null
TPA2012D2RTJT	null
TPA6130A2RTJR	null
TPA6130A2RTJT	null
TPA6132A2RTER	null
TPA6132A2RTET	null
TPS22965DSGR	null
TPS22965DSGT	null
TPS40192DRCR	null
TPS40192DRCT	null
TPS40193DRCR	null
TPS40193DRCT	null
TPS51200DRCR	null
TPS51200DRCT	null

TPS51220RHBT	null
TPS51622ARSMT	null
TPS51631RSMT	null
TPS53311RGTT	null
TPS53640RSBT	null
TPS53661RSBT	null
TPS62131RGTT	null
TPS62132RGTR	null
TPS62132RGTT	null
TPS62133RGTR	null
TPS62133RGTT	null
TPS62140RGTR	null
TPS62140RGTT	null
TPS62141RGTT	null
TPS62142RGTR	null
TPS62142RGTT	null
TPS62143RGTR	null
TPS62143RGTT	null
TPS62150ARGTT	null
TPS62150RGTR	null
TPS62150RGTT	null
TPS62151RGTT	null
TPS62152RGTT	null
TPS62153RGTR	null
TPS62153RGTT	null
TPS74201RGWR	null
TPS74401RGWR	null
TPS74401RGWT	null
TPS74701DRCR	null
TPS74701DRCT	null
TPS7A8001DRBR	null
TPS7A8001DRBT	null

Technical details of this Product Change follow on the next page(s).

<b>PCN Number:</b>	20141204000	<b>PCN Date:</b>	12/16/2014
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<b>Title:</b>	Qualification of TI Chengdu (CDAT) as Additional Assembly and Test Site for Select VQFN/WQFN Package Devices		
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<b>Customer Contact:</b>	<a href="#">PCN Manager</a>	<b>Phone:</b>	+1(214)480-6037	<b>Dept:</b>	Quality Services
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<b>Proposed 1<sup>st</sup> Ship Date:</b>	03/16/2015	<b>Estimated Sample Availability:</b>	Date Provided at Sample request
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<b>Change Type:</b>					
<input checked="" type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Design	<input type="checkbox"/>	Wafer Bump Site
<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Data Sheet	<input type="checkbox"/>	Wafer Bump Material
<input type="checkbox"/>	Assembly Materials	<input type="checkbox"/>	Part number change	<input type="checkbox"/>	Wafer Bump Process
<input type="checkbox"/>	Mechanical Specification	<input checked="" type="checkbox"/>	Test Site	<input type="checkbox"/>	Wafer Fab Site
<input checked="" type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process	<input type="checkbox"/>	Wafer Fab Materials
		<input type="checkbox"/>		<input type="checkbox"/>	Wafer Fab Process

**PCN Details**

**Description of Change:**

Texas Instruments Incorporated is announcing the qualification of TI Chengdu (CDAT) as Additional Assembly and Test Site for select devices listed in the "Product Affected" Section. Current assembly sites are as follows.

	Existing Sites	Additional Site
<b>Assembly/Test Sites</b>	TI-CLARK, CARZ, NSE	CDAT

Test coverage, insertions, conditions will remain consistent with current testing and verified with test MQ.

**Reason for Change:**

Continuity of supply.

**Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):**

None

**Changes to product identification resulting from this PCN:**

Assembly Site	Origin	ASO
TI-CLARK	Assembly Site Origin (22L)	ASO: QAB
CARZ	Assembly Site Origin (22L)	ASO: CSZ
NSE	Assembly Site Origin (22L)	ASO: NSE
TI Chengdu (CDAT)	Assembly Site Origin (22L)	ASO: CDA

ASSEMBLY SITE CODES: TI-CLARK = I , CARZ = F , NSE = J, CDAT = 8

Sample product shipping label (not actual product label)

 <p>MADE IN: Malaysia 2DC: 2Q:</p> <table border="1"> <tr> <td>MSL 2 / 260C / 1 YEAR</td> <td>SEAL DT</td> </tr> <tr> <td>MSL 1 / 235C / UNLIM</td> <td>03/29/04</td> </tr> </table> <p>OPT: ITEM: 39 LBL: 5A (L)T0:1750</p>	MSL 2 / 260C / 1 YEAR	SEAL DT	MSL 1 / 235C / UNLIM	03/29/04	 	<p>(1P) SN74LS07NSR  (Q) 2000 (D) 0336  (31T) LOT: 3959047MLA  (4W) TKY (1T) 7523483SI2  (P)  (2P) REV: (V) 0033317  (20L) CSO: SHE (21L) CCO:USA  (22L) ASO: MLA (23L) ACO: MYS</p>
MSL 2 / 260C / 1 YEAR	SEAL DT					
MSL 1 / 235C / UNLIM	03/29/04					

**Product Affected: Group 1 – VQFN Package**

BQ24190RGER	MSP430G2113IRHB32T	SN2806RGER	TPS53310RGTT
BQ24190RGET	MSP430G2153IRHB32R	SN2806RGET	TPS53311RGTR
BQ24192HRGER	MSP430G2153IRHB32T	SN2807RGER	TPS53311RGTT
BQ24192HRGET	MSP430G2203IRHB32R	SN2807RGET	TPS62131RGTR
BQ24192IRGER	MSP430G2203IRHB32T	SN2808RGER	TPS62131RGTT
BQ24192IRGET	MSP430G2213IRHB32R	SN2808RGET	TPS62132RGTR
BQ24192RGER	MSP430G2213IRHB32T	SN2816RGER	TPS62132RGTT
BQ24192RGET	MSP430G2233IRHB32R	SN2816RGET	TPS62133RGTR
BQ24193HRGER	MSP430G2233IRHB32T	SN2910RGER	TPS62133RGTT
BQ24193HRGET	MSP430G2253IRHB32R	SN2910RGET	TPS62140RGTR
BQ24193RGER	MSP430G2253IRHB32T	TLV62065DSGR	TPS62140RGTT
BQ24193RGET	MSP430G2303IRHB32R	TLV62065DSGT	TPS62141RGTR
BQ24195LRGER	MSP430G2303IRHB32T	TLV62130ARGTR	TPS62141RGTT
BQ24195LRGET	MSP430G2313IRHB32R	TLV62130ARGTT	TPS62142RGTR
BQ24196RGER	MSP430G2313IRHB32T	TLV62130RGTR	TPS62142RGTT
BQ24196RGET	MSP430G2333IRHB32R	TLV62130RGTT	TPS62143RGTR
BQ24232HRGTR	MSP430G2333IRHB32T	TLV62150ARGTR	TPS62143RGTT
BQ24232HRGTT	MSP430G2353IRHB32R	TLV62150ARGTT	TPS62150ARGTR
BQ24232RGTR	MSP430G2353IRHB32T	TLV62150RGTR	TPS62150ARGTT
BQ24232RGTT	MSP430G2403IRHB32R	TLV62150RGTT	TPS62150RGTR
BQ24295RGER	MSP430G2403IRHB32T	TPS22965DSGR	TPS62150RGTT
BQ24295RGET	MSP430G2413IRHB32R	TPS22965DSGT	TPS62151RGTR
BQ24296MRGER	MSP430G2413IRHB32T	TPS40192DRCR	TPS62151RGTT
BQ24296MRGET	MSP430G2433IRHB32R	TPS40192DRCT	TPS62152RGTR
BQ24296RGER	MSP430G2433IRHB32T	TPS40193DRCR	TPS62152RGTT
BQ24296RGET	MSP430G2453IRHB32R	TPS40193DRCT	TPS62153RGTR
BQ24297RGER	MSP430G2453IRHB32T	TPS51200DRCR	TPS62153RGTT
BQ24297RGET	MSP430G2513IRHB32R	TPS51200DRCT	TPS65262-1RHBR
MSP430F2112IRHBR	MSP430G2513IRHB32T	TPS51220RHBR	TPS65262-1RHBT
MSP430F2112IRHBT	MSP430G2533IRHB32R	TPS51220RHBT	TPS65262RHBR
MSP430F2112TRHBR	MSP430G2533IRHB32T	TPS51220RRHBR	TPS65262RHBT
MSP430F2112TRHBT	MSP430G2553IRHB32R	TPS51311RGTR	TPS74201RGWR
MSP430F2122IRHBR	MSP430G2553IRHB32T	TPS51622ARSMR	TPS74201RGWT
MSP430F2122IRHBT	MSP430TCH5ERHBR	TPS51622ARSMT	TPS74401RGWR
MSP430F2122TRHBR	MSP430TCH5ERHBT	TPS51622RSMR	TPS74401RGWT
MSP430F2122TRHBT	MSP430V258IRHBR	TPS51622RSMT	TPS74701DRCR
MSP430F2132IRHBR	MSP430V386IRHB32R	TPS51624RSMR	TPS74701DRCT
MSP430F2132IRHBT	MSP430V402IRHB32R	TPS51624RSMT	TPS7A8001DRBR
MSP430F2132TRHBR	MSP430V592IRHB32R	TPS51631RSMR	TPS7A8001DRBT
MSP430F2132TRHBT	SN0774401RGWR	TPS51631RSMT	
MSP430G2113IRHB32R	SN0774401RGWT	TPS53310RGTR	

**Product Affected: Group 2 – WQFN package**

BQ24040DSQR	TPA2012D2RTJT	TPS51220ARSNR	TPS53640RSBT
BQ24040DSQT	TPA6130A2RTJR	TPS51220ARSNT	TPS53641RSBR
SN1304056RSBR	TPA6130A2RTJT	TPS53631RSBR	TPS53641RSBT
SN1304056RSBT	TPA6132A2RTER	TPS53631RSBT	TPS53661RSBR
SN1304057RSBR	TPA6132A2RTET	TPS53640ARSBR	TPS53661RSBT
SN1304057RSBT	TPA6133A2RTJR	TPS53640ARSBT	
TPA2012D2RTJR	TPA6133A2RTJT	TPS53640RSBR	

## Group 1: Qualification Status Report

### Chengdu A/T Qualification of VQFN/VSON packages

#### Product Attributes

Attributes	Qual Device 1: BQ24196RGER	Qual Device 2: TPS40192DRCR	Qual Device: 3 TPS51200DRCR	Qual Device 4: TPS51622RSMR
<b>Assembly Site</b>	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T
<b>Package Family</b>	VQFN	VSON	VSON	VQFN
<b>Die Attributes</b>				
<b>Die Revision</b>	A	A	B	A
<b>Wafer Fab Site</b>	RFAB	DFAB 200MM	RFAB	RFAB
<b>Wafer Fab Process</b>	LBC7	LBC4	LBC7	LBC7
<b>Package Attributes</b>				
<b>Package Designator</b>	RGE	DRC	DRC	RSM
<b>Package Size (mils)</b>	157.48 X 157.48	118.11 X 118.11	118.11 X 118.11	157.48 X 157.48
<b>Body Thickness (mils)</b>	35.43	35.43	35.43	35.43
<b>Pin Count</b>	24	10	10	32
<b>Lead Frame Material</b>	Cu	Cu	Cu	Cu
<b>Lead Finish</b>	NIPDAU	NiPdAu	NiPdAu	NiPdAu
<b>Lead Pitch (mils)</b>	19.68	19.68	19.68	15.75
<b>Mount Compound</b>	4207123	4207768	4207768	4207768
<b>Mold Compound</b>	4208625	4208625	4208625	4208625
<b>Bond Wire Composition</b>	Cu	Cu	Cu	Cu
<b>Bond Wire Diameter (mils)</b>	1.98	0.96	0.96	0.96
<b>Flammability Rating</b>	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0

Attributes	Qual Device 5: TPS62140RGTR	Qual Device 6: TPS65262RHBR	Qual Device 7: TPS7A8001DRBR	Qual Device 8: MSP430G2553IRHB
<b>Assembly Site</b>	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T
<b>Package Family</b>	VQFN	VQFN	VSON	VQFN
<b>Die Attributes</b>				
<b>Die Revision</b>	F	A2	A	C
<b>Wafer Fab Site</b>	MIHO8	RFAB	RFAB	TSMC FAB 10
<b>Wafer Fab Process</b>	LBC7	LBC7	LBC7	TSMC.035 EMB FLASH
<b>Package Attributes</b>				
<b>Package Designator</b>	RGT	RHB	DRB	RHB
<b>Package Size (mils)</b>	118.11 X 118.11	196.85 X 196.85	118.11 X 118.11	196.85 X 196.85

<b>Body Thickness (mils)</b>	35.43	35.43	35.43	35.43
<b>Pin Count</b>	16	32	8	32
<b>Lead Frame Material</b>	CU	CU	Cu	CU
<b>Lead Finish</b>	NiPdAu	NiPdAu	NiPdAu	NIPDAU
<b>Lead Pitch (mils)</b>	19.68	19.68	25.59	19.68
<b>Mount Compound</b>	4207768	4207768	4207768	4207768
<b>Mold Compound</b>	4208625	4208625	4208625	4208625
<b>Bond Wire Composition</b>	Cu	Cu	Cu	Cu
<b>Bond Wire Diameter (mils)</b>	1.3	1.98	0.96	0.96
<b>Flammability Rating</b>	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0

- QBS: Qual By Similarity

- Qual Devices qualified at LEVEL2-260C: BQ24196RGER, TPS40192DRCR, TPS51200DRCR, TPS51622RSMR, TPS62140RGTR, TPS65262RHBR, TPS7A8001DRBR, MSP430G2553IRHB

### Qualification Plan

Type	Test Name / Condition	Duration	Qual Device 1: BQ24196RGER	Qual Device 2: TPS40192DRCR	Qual Device 3: TPS51200DRCR	Qual Device 4: TPS51622RSMR
AC	Autoclave 121C	96 Hours	2/8/2015		2/8/2015	2/8/2015
HAST	Biased HAST, 130C/85%RH	96 Hours				
TC	Temperature Cycle, -65/+150C	500 Cycles	2/24/2015		2/24/2015	2/24/2015
HTSL	High Temp Storage Bake 170C	420 Hours	2/19/2015		2/19/2015	2/19/2015
HTOL	Life Test 150C	300 Hours				
SD	Solderability	Pb free	1/30/2015			
PD	Physical Dimensions	(per mechanical drawing)	2/9/2015	2/9/2015	2/9/2015	2/9/2015
ED	Electrical Characterization	Per Datasheet Parameters	2/9/2015	2/9/2015	2/9/2015	2/9/2015
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	2/9/2015	2/9/2015	2/9/2015	2/9/2015
TIS	Thermal Integrity Sequence	Level 2 @260C	3/9/2015			
VM	Visual Quality Reliability Inspection	Post Autoclave 96 Hours	3/9/2015		3/9/2015	3/9/2015
VM	Visual Quality Reliability Inspection	Post Temp Cycle 500 Cycles	3/15/2015		3/15/2015	3/15/2015
MECH	Visual / Mechanical	(per mfg. Site specification)	2/9/2015	2/9/2015	2/9/2015	2/9/2015
WBS	Ball Bond Shear	76 wires	2/9/2015	2/9/2015	2/9/2015	2/9/2015
WBP	Wire Pull	76 wires	2/9/2015	2/9/2015	2/9/2015	2/9/2015

Type	Test Name / Condition	Duration	Qual Device 5: TPS62140RGTR	Qual Device 6: TPS65262RHBR	Qual Device 7: TPS7A8001DRBR	Qual Device 8: MSP430G2553IRHB
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AC	Autoclave 121C	96 Hours	2/8/2015		2/8/2015	2/11/2015
HAST	Biased HAST, 130C/85%RH	96 Hours	2/8/2015			2/18/2015
TC	Temperature Cycle, -65/+150C	500 Cycles	2/24/2015	2/24/2015	2/24/2015	2/18/2015
HTSL	High Temp Storage Bake 170C	420 Hours	2/19/2015		2/19/2015	2/26/2015
HTOL	Life Test 150C	300 Hours				3/3/2015
SD	Solderability	Pb free	1/30/2015	1/30/2015		1/30/2015
PD	Physical Dimensions	(per mechanical drawing)	2/9/2015	2/9/2015	2/9/2015	1/30/2015
ED	Electrical Characterization	Per Datasheet Parameters	2/9/2015	2/9/2015	2/9/2015	
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	2/9/2015	2/9/2015	2/9/2015	1/15/2015
TIS	Thermal Integrity Sequence	Level 2 @260C	3/9/2015			1/23/2015
VM	Visual Quality Reliability Inspection	Post Autoclave 96 Hours	3/9/2015		3/9/2015	3/3/2015
VM	Visual Quality Reliability Inspection	Post Temp Cycle 500 Cycles	3/15/2015	3/15/2015	3/15/2015	3/3/2015
MECH	Visual / Mechanical	(per mfg. Site specification)	2/9/2015	2/9/2015	2/9/2015	1/30/2015
WBS	Ball Bond Shear	76 wires	2/9/2015	2/9/2015	2/9/2015	1/15/2015
WBP	Wire Pull	76 wires	2/9/2015	2/9/2015	2/9/2015	1/15/2015

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

**Green/Pb-free Status:**

Qualified Pb-Free(SMT) and Green

## Group 2: Qualification Status Report

### Chengdu A/T Qualification of WQFN packages

#### Product Attributes

Attributes	Qual Device 1: TPA2012D2RTJT	Qual Device 2: TPS51220ARSNR	Qual Device 3: TPS53641RSBR	QBS Qual Device 4: TPS51622RSMR
<b>Assembly Site</b>	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T
<b>Package Family</b>	WQFN	WQFN	WQFN	WQFN
<b>Die Attributes</b>				
<b>Die Revision</b>	A	B	A	A
<b>Wafer Fab Site</b>	FFAB	RFAB	RFAB	RFAB
<b>Wafer Fab Process</b>	3370A12X3	LBC7	LBC7	LBC7
<b>Package Attributes</b>				
<b>Assembly Site</b>	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T	CHENGDU A/T



<b>Package Family</b>	WQFN	WQFN	WQFN	VQFN
<b>Package Designator</b>	RTJ	RSN	RSB	RSM
<b>Package Size (mils)</b>	157.48 X 157.48	157.48 X 157.48	196.85 X 196.85	157.48 X 157.48
<b>Body Thickness (mils)</b>	29.53	29.53	29.53	35.43
<b>Pin Count</b>	20	32	40	32
<b>Lead Frame Material</b>	Cu	Cu	CU	Cu
<b>Lead Finish</b>	NiPdAu	NIPDAU	NIPDAU	NiPdAu
<b>Lead Pitch (mils)</b>	19.68	15.75	15.75	15.75
<b>Mount Compound</b>	4207123	4207123	4207123	4207123
<b>Mold Compound</b>	4208625	4208625	4208625	4208625
<b>Bond Wire Composition</b>	Cu	Cu	Cu	Cu
<b>Bond Wire Diameter (mils)</b>	0.96	0.96	0.96	0.96
<b>Flammability Rating</b>	UL 94 V-0	UL 94 V-0	UL 94 V-0	UL 94 V-0

- QBS: Qual By Similarity

- Qual Devices qualified at LEVEL2-260C: TPA2012D2RTJT, TPS51220ARSNR, TPS53641RSBR, TPS51622RSMR

## Qualification Plan

Type	Test Name / Condition	Duration	Qual Device 1: TPA2012D2RTJT	Qual Device 2: TPS51220ARSNR	Qual Device 3: TPS53641RSBR	QBS Qual Device 4: TPS51622RSMR
AC	Autoclave 121C	96 Hours			4/1/2015	2/8/2015
TC	Temperature Cycle, -65/+150C	500 Cycles			4/1/2015	2/24/2015
HTSL	High Temp Storage Bake 170C	420 Hours				2/19/2015
PD	Physical Dimensions	(per mechanical drawing)	4/1/2015	4/1/2015	4/1/2015	2/9/2015
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	4/1/2015	4/1/2015	4/1/2015	2/9/2015
TIS	Thermal Integrity Sequence	Level 2 @260C			3/15/2015	
VM	Visual Quality Reliability Inspection	Post Autoclave 96 Hours				3/9/2015
VM	Visual Quality Reliability Inspection	Post Temp Cycle 500 Cycles				3/15/2015
MECH	Visual / Mechanical	(per mfg. Site specification)	4/1/2015	4/1/2015	4/1/2015	2/9/2015
WBS	Ball Bond Shear	76 wires	4/1/2015	4/1/2015	4/1/2015	2/9/2015
WBP	Wire Pull	76 wires	4/1/2015	4/1/2015	4/1/2015	2/9/2015

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: <http://www.ti.com/>

### **Green/Pb-free Status:**

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

<b>Location</b>	<b>E-Mail</b>
USA	<a href="mailto:PCNAmericasContact@list.ti.com">PCNAmericasContact@list.ti.com</a>
Europe	<a href="mailto:PCNEuropeContact@list.ti.com">PCNEuropeContact@list.ti.com</a>
Asia Pacific	<a href="mailto:PCNAsiaContact@list.ti.com">PCNAsiaContact@list.ti.com</a>
Japan	<a href="mailto:PCNJapanContact@list.ti.com">PCNJapanContact@list.ti.com</a>